

FDMT80060DC N-Channel Dual CoolTM 88 PowerTrench[®] MOSFET **60 V, 292 A, 1.1 m**Ω

Features

- Max $r_{DS(on)}$ = 1.1 m Ω at V_{GS} = 10 V, I_D = 43 A
- Max $r_{DS(on)}$ = 1.3 m Ω at V_{GS} = 8 V, I_D = 37 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- Low profile 8x8mm MLP package
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

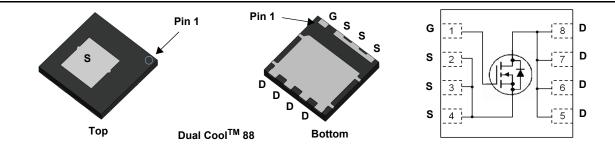


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. Advancements in both silicon and Dual $\operatorname{Cool}^{\mathsf{TM}}$ package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Symbol	Paramo	eter		Ratings	Units
V _{DS}	Drain to Source Voltage			60	V
V _{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25 °C	(Note 5)	292	
	-Continuous	T _C = 100°C	(Note 5)	184	^
D	-Continuous	T _A = 25 °C	(Note 1a)	43	Α
	-Pulsed		(Note 4)	1825	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	2400	mJ
P _D	Power Dissipation	T _C = 25 °C		156	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	3.2	vv
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
80060DC	FDMT80060DC	Dual Cool TM 88	13"	13.3 mm	3000 units

August 2015

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	60			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		30		mV/°C
DSS	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μA
GSS	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA
On Chara	octeristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	2.0	3.5	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		-13		mV/°C
0		V _{GS} = 10 V, I _D = 43 A		0.87	1.1	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 8 V, I _D = 37 A		1.1	1.3	mΩ
20(01)		V _{GS} = 10 V, I _D = 43 A, T _J = 125 °C		1.3	1.7	
9 _{FS}	Forward Transconductance	$V_{DS} = 5 V, I_D = 43 A$		134		S
	Input Capacitance	$V_{\text{DO}} = 30 \text{ V}$ $V_{\text{OO}} = 0 \text{ V}$		14406	20170	pF
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance			3222 87	4515 175	pF pF
C _{oss} C _{rss} R _g	Output Capacitance Reverse Transfer Capacitance Gate Resistance		0.1	3222	4515	pF
C _{oss} C _{rss} R _g Switchinç	Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics		0.1	3222 87 1.8	4515 175 4.5	pF pF Ω
C _{oss} C _{rss} R _g Switching	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time	f = 1 MHz	0.1	3222 87 1.8 75	4515 175 4.5 120	pF pF Ω ns
C _{oss} C _{rss} Rg Switching t _{d(on)}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time	f = 1 MHz V _{DD} = 30 V, I _D = 43 A,	0.1	3222 87 1.8 75 47	4515 175 4.5 120 76	pF pF Ω ns ns
C _{oss} C _{rss} Rg Switching id(on) ir id(off)	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	f = 1 MHz	0.1	3222 87 1.8 75 47 66	4515 175 4.5 120 76 106	pF pF Ω ns ns ns
C _{oss} C _{rss} Rg Switching id(on) ir id(off) if	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	f = 1 MHz V _{DD} = 30 V, I _D = 43 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	0.1	3222 87 1.8 75 47 66 19	4515 175 4.5 120 76 106 34	pF pF Ω ns ns ns
C _{oss} C _{rss} Switching ta(on) tr ta(off) tf Q _{g(TOT)}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	f = 1 MHz V _{DD} = 30 V, I _D = 43 A, V _{GS} = 10 V, R _{GEN} = 6 Ω V _{GS} = 0 V to 10 V	0.1	3222 87 1.8 75 47 66 19 170	4515 175 4.5 120 76 106 34 238	pF pF Ω ns ns ns ns nc
C _{oss} C _{rss} Switching Switching t _{d(off)} t _f Q _{g(TOT)} Q _{g(TOT)}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	f = 1 MHz V _{DD} = 30 V, I _D = 43 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	0.1	3222 87 1.8 75 47 66 19	4515 175 4.5 120 76 106 34	pF pF Ω ns ns ns
C _{oss} C _{rss} Switching Switching ta(on) tr ta(off) ta Q _{g(TOT)} Q _{g(TOT)} Q _{gs}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$f = 1 \text{ MHz}$ $V_{DD} = 30 \text{ V}, I_D = 43 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 8 \text{ V}$ $V_{DD} = 30 \text{ V},$	0.1	3222 87 1.8 75 47 66 19 170 137	4515 175 4.5 120 76 106 34 238	pF pF Ω ns ns ns nc nC
C _{oss} C _{rss} R g Switchinş t ^d (on) tr t Qg(TOT) Qg(TOT) Qgs Qgd	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$f = 1 \text{ MHz}$ $V_{DD} = 30 \text{ V}, I_D = 43 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 8 \text{ V}$ $V_{DD} = 30 \text{ V},$	0.1	3222 87 1.8 75 47 66 19 170 137 71	4515 175 4.5 120 76 106 34 238	pF pF Ω ns ns ns nC nC
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \\ \hline C_{rss} \\ \hline \\ $	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$f = 1 \text{ MHz}$ $V_{DD} = 30 \text{ V}, I_D = 43 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 8 \text{ V}$ $V_{DD} = 30 \text{ V},$	0.1	3222 87 1.8 75 47 66 19 170 137 71	4515 175 4.5 120 76 106 34 238	pF pF Ω ns ns ns nc nC nC nC
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \\ \hline C_{rss} \\ \hline \\ $	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$ \begin{array}{c} f = 1 \text{ MHz} \\ \\ V_{DD} = 30 \text{ V}, \text{ I}_{D} = 43 \text{ A}, \\ V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega \\ \\ \hline V_{GS} = 0 \text{ V to } 10 \text{ V} \\ \hline V_{GS} = 0 \text{ V to } 8 \text{ V} \\ \\ \hline I_{D} = 43 \text{ A} \end{array} $	0.1	3222 87 1.8 75 47 66 19 170 137 71 19	4515 175 4.5 120 76 106 34 238 192	pF pF Ω ns ns ns nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _{g(TOT)} Q _{g(TOT)} Q _{gs} Q _{gd}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$ \begin{array}{c} f = 1 \text{ MHz} \\ \\ V_{DD} = 30 \text{ V}, \text{ I}_{D} = 43 \text{ A}, \\ V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega \\ \\ \hline V_{GS} = 0 \text{ V to } 10 \text{ V} \\ \hline V_{GS} = 0 \text{ V to } 8 \text{ V} \\ \\ I_{D} = 43 \text{ A} \\ \end{array} $	0.1	3222 87 1.8 75 47 66 19 170 137 71 19 0.7	4515 175 4.5 120 76 106 34 238 192 1.1	pF pF Ω ns ns ns nc nC nC nC

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Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	26	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1e)	14	°C 1.11
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1f)	16	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1h)	60	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1I)	11	

NOTES:

1. R_{0JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0CA} is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper



c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper

- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper

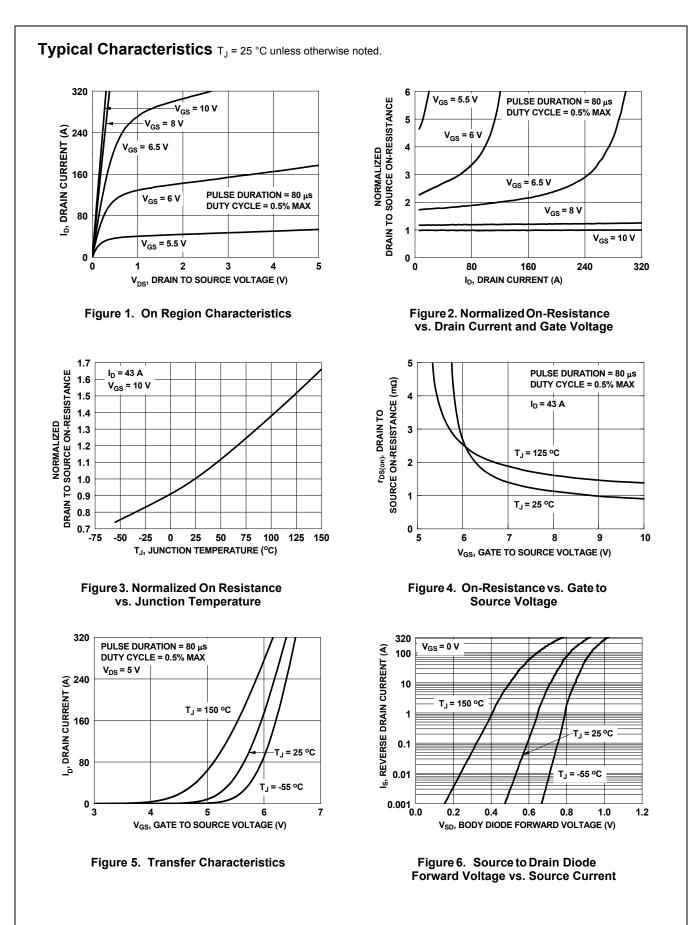
I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

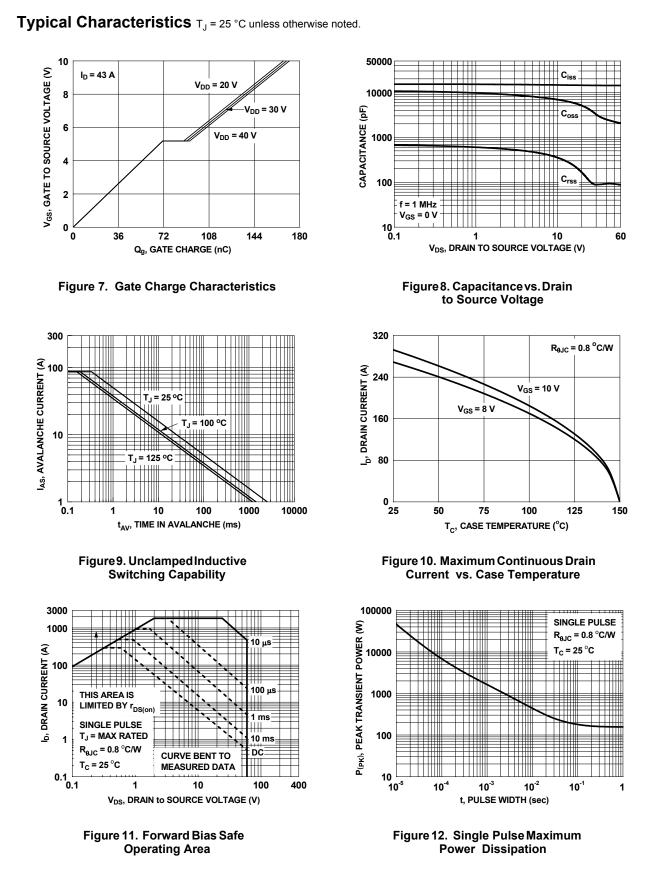
3. E_{AS} of 2400 mJ is based on starting T_J = 25 °C; N-ch: L = 3 mH, I_{AS} = 40 A, V_{DD} = 60 V, V_{GS} = 10 V. 100% test at L = 0.3mH, I_{AS} = 87 A.

4. Pulsed Id please refer to Fig 11 SOA graph for more details.

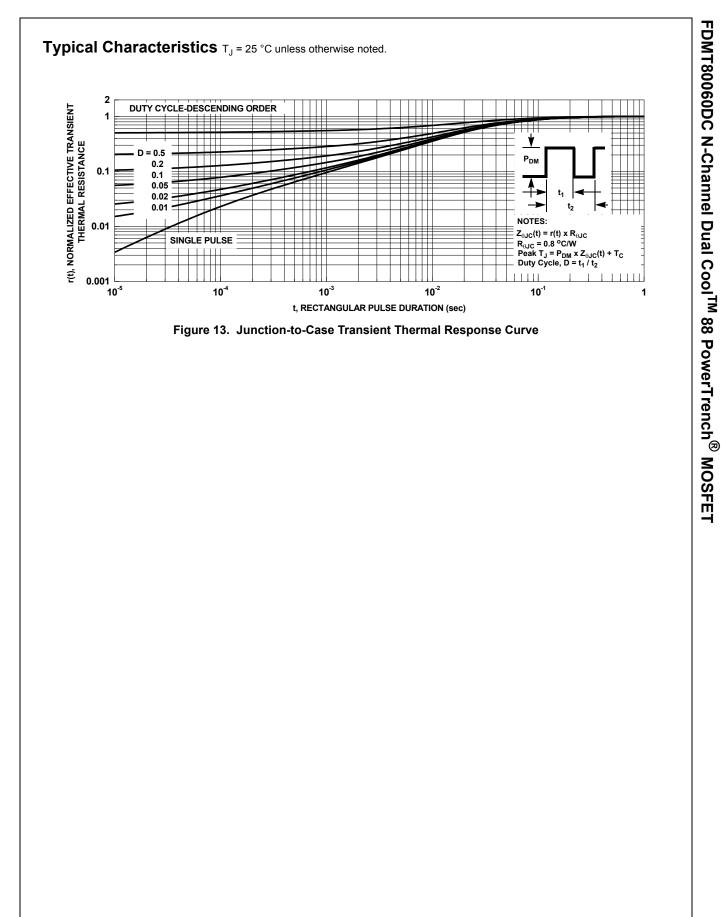
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

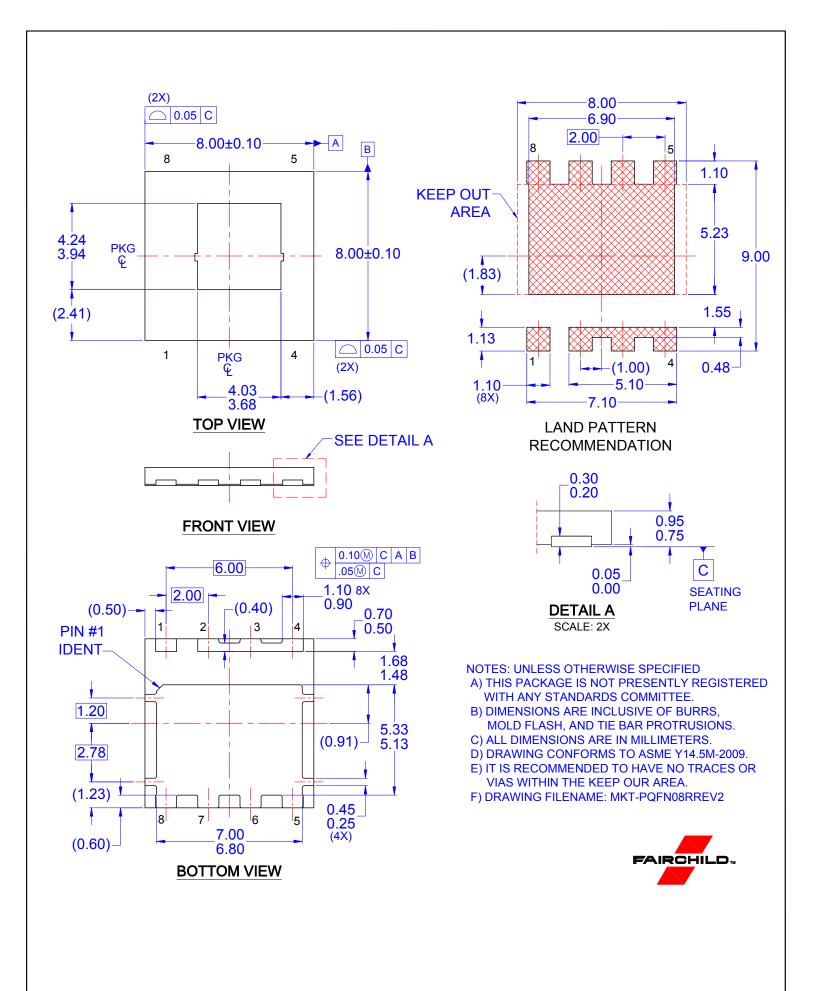


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